

Lecture 4

Electrons and Holes in Semiconductors

In this lecture you will learn:

- Generation-recombination in semiconductors in more detail
- The basic set of equations governing the behavior of electrons and holes in semiconductors
- Shockley Equations
- Quasi-neutrality in conductive materials

Majority and Minority Carriers

In N-doped Semiconductors:

Electrons are the majority carriers
Holes are the minority carriers

In P-doped Semiconductors:

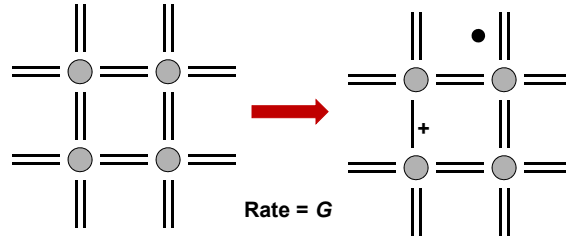
Holes are the majority carriers
Electrons are the minority carriers

Golden Rule of Thumb:

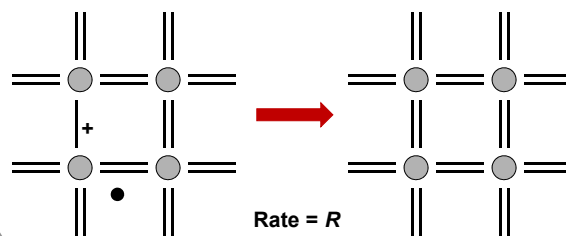
When trying to understand semiconductor devices, always first see what the minority carriers are doing

Generation and Recombination in Semiconductors

Generation process:



Recombination process:



We can write the following equations for the carrier densities:

$$\frac{\partial n(t)}{\partial t} = G - R$$

$$\frac{\partial p(t)}{\partial t} = G - R$$

These equations tell how the electron and hole densities change in time as a result of recombination and generation processes

Generation and Recombination in Thermal Equilibrium

- From the first lecture, in **thermal equilibrium**:

The recombination rate = $R_o = k n_o p_o$
equals the generation rate = G_o

$$\text{i.e. } G_o = R_o$$

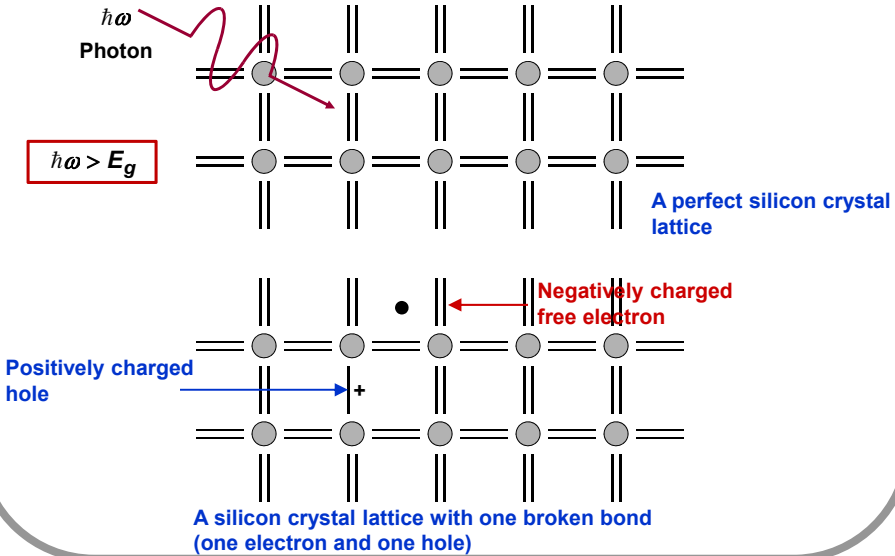
- Then in thermal equilibrium:

$$\frac{\partial n_o(t)}{\partial t} = G_o - R_o = 0$$

$$\frac{\partial p_o(t)}{\partial t} = G_o - R_o = 0$$

Light Absorption in Semiconductors

Generation of electrons and holes by photons in semiconductors:



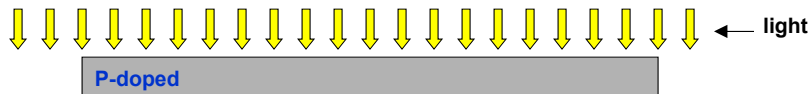
Generation and Recombination Out of Thermal Equilibrium

1) Consider a P-doped slab of Silicon:

P-doped ($n_o \ll p_o$)

Electron-hole recombination rate in thermal equilibrium = $R_o = k n_o p_o$
 equals the generation rate = $G_o = k n_i^2$

2) Now turn light on at time $t = 0$:



• Light breaks the Si-Si covalent bonds and generates excess electron-hole pairs

• The net generation rate now becomes: $G = G_o + G_L$

extra part

3) Mathematical model of the above situation:

$$\left. \begin{aligned} n &= n_o + n'(t) \\ p &= p_o + p'(t) \end{aligned} \right\}$$

• $n'(t)$ and $p'(t)$ are the **excess** electron and hole densities

• It must be that: $n'(t) = p'(t)$

• We also assume that: $n'(t), p'(t) \ll p_o$

Generation and Recombination Out of Thermal Equilibrium

- We can use the equations:

$$\left. \begin{aligned} \frac{\partial n(t)}{\partial t} = G - R \\ \frac{\partial p(t)}{\partial t} = G - R \end{aligned} \right\} \begin{aligned} n &= n_o + n'(t) \\ p &= p_o + p'(t) \end{aligned}$$

- **Generation rate:**

$$G = G_o + G_L$$

- **Recombination rate:**

$$\begin{aligned} R &= k n p \\ &= k (n_o + n') (p_o + p') \\ &\approx k (n_o + n') p_o \\ &= k n_o p_o + k n' p_o \\ &= R_o + \frac{n'}{\tau_n} \end{aligned}$$

Assumptions: $n', p' \ll p_o$

$$\left. \begin{aligned} \frac{1}{\tau_n} = k p_o \end{aligned} \right\} \tau_n \text{ is the lifetime of the minority carriers (i.e. electrons)}$$

The excess recombination rate is proportional to the excess MINORITY carrier density

- The equation for **excess minority carriers** (i.e. electrons) becomes:

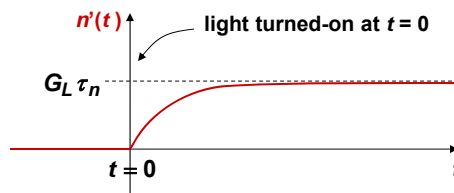
$$\frac{\partial n(t)}{\partial t} = G - R \quad \longrightarrow \quad \frac{\partial n'(t)}{\partial t} = G_o + G_L - R_o - \frac{n'(t)}{\tau_n} \quad \longrightarrow \quad \frac{\partial n'(t)}{\partial t} = G_L - \frac{n'(t)}{\tau_n}$$

Generation and Recombination Out of Thermal Equilibrium

$$\frac{\partial n'(t)}{\partial t} = G_L - \frac{n'(t)}{\tau_n}$$

- Solution with the boundary condition, $n'(t=0) = 0$, is:

$$n'(t) = G_L \tau_n \left(1 - e^{-\frac{t}{\tau_n}} \right)$$



- Excess hole density is, of course :

$$p'(t) = n'(t)$$

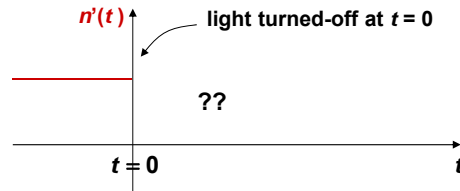
- As $t \rightarrow \infty$ the excess electron and hole densities reach a steady state value

$$\begin{aligned} n'(t \rightarrow \infty) &= G_L \tau_n & \text{and} & & n(t \rightarrow \infty) &= n_o + G_L \tau_n \\ p'(t \rightarrow \infty) &= G_L \tau_n & & & p(t \rightarrow \infty) &= p_o + G_L \tau_n \end{aligned}$$

Generation and Recombination Out of Thermal Equilibrium

Now suppose that light had been turned-on for a very very long time and it was turned-off at time $t = 0$

$$\begin{aligned} \text{At time } t = 0: \quad n' &= G_L \tau_n & \text{and} & & n &= n_o + G_L \tau_n \\ p' &= G_L \tau_n & & & p &= p_o + G_L \tau_n \end{aligned}$$



- Since $n \neq n_o$, and $p \neq p_o$, the carrier densities are not equal to their thermal equilibrium values. Thermal equilibrium must get restored since the light has been turned-off

Question: How does thermal equilibrium gets restored??

Generation and Recombination Out of Thermal Equilibrium

- We can use the equations:

$$\left. \begin{aligned} \frac{\partial n(t)}{\partial t} &= G - R & \frac{\partial p(t)}{\partial t} &= G - R \end{aligned} \right\} \begin{aligned} n &= n_o + n'(t) \\ p &= p_o + p'(t) \end{aligned}$$

- **Generation rate:**

$$G = G_o$$

- **Recombination rate:**

$$\begin{aligned} R &= k n p \\ &= k (n_o + n') (p_o + p') \\ &\approx k (n_o + n') p_o \\ &= k n_o p_o + k n' p_o \\ &= R_o + \frac{n'}{\tau_n} \end{aligned}$$

Assumptions: $n', p' \ll p_o$

The excess recombination rate is proportional to the excess MINORITY carrier density

- The equation for **excess minority carriers** (i.e. electrons) becomes:

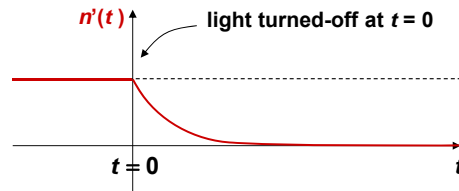
$$\frac{\partial n(t)}{\partial t} = G - R \quad \longrightarrow \quad \frac{\partial n'(t)}{\partial t} = G_o - R_o - \frac{n'(t)}{\tau_n} \quad \longrightarrow \quad \frac{\partial n'(t)}{\partial t} = G_L - \frac{n'(t)}{\tau_n}$$

Generation and Recombination Out of Thermal Equilibrium

$$\frac{\partial n'(t)}{\partial t} = -\frac{n'(t)}{\tau_n}$$

• Solution is:

$$n'(t) = n'(t=0) e^{-\frac{t}{\tau_n}} \Rightarrow \text{Excess electron density decays exponentially to zero from its initial value}$$



The excess carrier densities decay with time and thermal equilibrium values for carrier densities are restored

• The excess hole density will also decay in the same way: $p'(t) = p'(t=0) e^{-\frac{t}{\tau_p}}$

• As $t \rightarrow \infty$ the electron and hole densities reach their equilibrium values:

$$\begin{matrix} n'(t \rightarrow \infty) = 0 \\ p'(t \rightarrow \infty) = 0 \end{matrix} \quad \text{and} \quad \begin{matrix} n(t \rightarrow \infty) = n_o \\ p(t \rightarrow \infty) = p_o \end{matrix}$$

Generation and Recombination in Doped Semiconductors

Whenever you have to find an expression for R use the following recipe:

• If it is a **p-doped semiconductor**:

$$R = R_o + \frac{n'(x,t)}{\tau_n} \quad \left. \vphantom{\frac{n'(x,t)}{\tau_n}} \right\} \tau_n \text{ is the minority carrier lifetime}$$

• If it is a **n-doped semiconductor**:

$$R = R_o + \frac{p'(x,t)}{\tau_p} \quad \left. \vphantom{\frac{p'(x,t)}{\tau_p}} \right\} \tau_p \text{ is the minority carrier lifetime}$$

The excess recombination rate (i.e. $R - R_o$) is always proportional to the excess MINORITY carrier density

Electron and Hole Current Density Equations

From last lecture.....

$$J_n(x) = qn(x)\mu_n E(x) + qD_n \frac{dn(x)}{dx} \quad (1)$$

$$J_p(x) = qp(x)\mu_p E(x) - qD_p \frac{dp(x)}{dx} \quad (2)$$

These are two of Shockley's equations !



William Shockley



John Bardeen



Walter Brattain

Shockley, Bardeen, and Brattain from Bell Labs were awarded the Nobel Prize for inventing the semiconductor transistor

Electron and Hole Current Continuity Equations

• You have already seen the equations:

$$\frac{\partial n(x,t)}{\partial t} = G - R$$

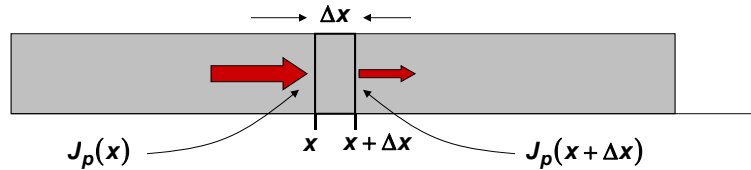
$$\frac{\partial p(x,t)}{\partial t} = G - R$$

These equations tell how the electron and hole densities change in time as a result of recombination and generation processes.

• Carrier densities can also change in time if the current densities change in space !!!

Electron and Hole Current Continuity Equations

Consider the infinitesimal strip between x and $x+\Delta x$



The difference in hole fluxes at x and $x+\Delta x$ must result in piling up of holes in the infinitesimal strip

$$J_p(x, t) - J_p(x + \Delta x, t) = q \frac{\partial p(x, t) \Delta x}{\partial t} \quad \left. \vphantom{J_p(x, t)} \right\} \text{Note that } q p(x, t) \text{ is the hole charge density}$$

$$\Rightarrow - \frac{J_p(x + \Delta x, t) - J_p(x, t)}{\Delta x} = q \frac{\partial p(x, t)}{\partial t}$$

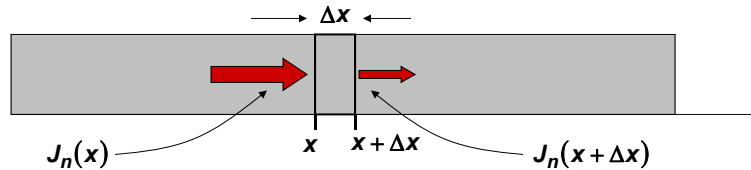
$$\Rightarrow - \frac{\partial J_p(x, t)}{\partial x} = q \frac{\partial p(x, t)}{\partial t} \quad \xrightarrow{\text{blue arrow}} \quad \frac{\partial p(x, t)}{\partial t} = - \frac{1}{q} \frac{\partial J_p(x, t)}{\partial x}$$

Now add **recombination** and **generation** to the above equation:

$$\frac{\partial p(x, t)}{\partial t} = G - R - \frac{1}{q} \frac{\partial J_p(x, t)}{\partial x}$$

Electron and Hole Current Continuity Equations - III

One can do the same for electrons as well.....



$$\frac{\partial n(x, t)}{\partial t} = G - R + \frac{1}{q} \frac{\partial J_n(x, t)}{\partial x}$$

So now we have two new equations,

$$\frac{\partial p(x, t)}{\partial t} = G - R - \frac{1}{q} \frac{\partial J_p(x, t)}{\partial x} \quad \text{----- (3)}$$

$$\frac{\partial n(x, t)}{\partial t} = G - R + \frac{1}{q} \frac{\partial J_n(x, t)}{\partial x} \quad \text{----- (4)}$$

These are two more of Shockley's equations !

Gauss's Law and Electrostatics

The net charge density in a semiconductor is,

$$\rho(x, t) = q[+ N_d(x) - N_a(x) + p(x, t) - n(x, t)]$$

Gauss's Law in differential form:

$$\frac{\partial E(x, t)}{\partial x} = \frac{\rho(x, t)}{\epsilon_s}$$

$$\frac{\partial E(x, t)}{\partial x} = \frac{q[+ N_d(x) - N_a(x) + p(x, t) - n(x, t)]}{\epsilon_s} \quad (5)$$

This is the fifth and the last of the Shockley's equations !

$$\begin{aligned} \epsilon_o &= 8.85 \times 10^{-12} \text{ Farads/m} \\ &= 8.85 \times 10^{-14} \text{ Farads/cm} \end{aligned}$$

$$\text{For Silicon: } \epsilon_s = 11.7 \epsilon_o$$

The Five Shockley Equations

$$J_n(x, t) = q n(x, t) \mu_n E(x, t) + q D_n \frac{d n(x, t)}{d x} \quad (1)$$

$$J_p(x, t) = q p(x, t) \mu_p E(x, t) - q D_p \frac{d p(x, t)}{d x} \quad (2)$$

$$\frac{\partial p(x, t)}{\partial t} = G - R - \frac{1}{q} \frac{\partial J_p(x, t)}{\partial x} \quad (3)$$

$$\frac{\partial n(x, t)}{\partial t} = G - R + \frac{1}{q} \frac{\partial J_n(x, t)}{\partial x} \quad (4)$$

$$\frac{\partial E(x, t)}{\partial x} = \frac{q[+ N_d(x) - N_a(x) + p(x, t) - n(x, t)]}{\epsilon_s} \quad (5)$$

Using these equations one can understand the behavior of semiconductor microelectronic devices !!

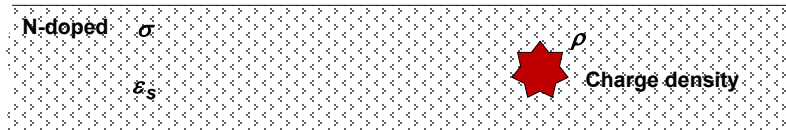
Quasi-Neutrality

Materials with large conductivities are "quasi-neutral"

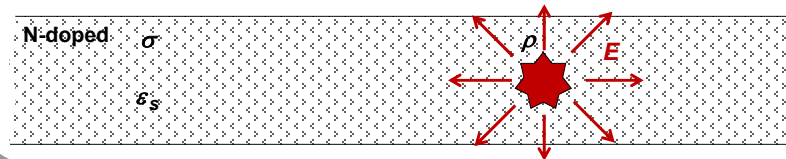
"Quasi-neutrality" implies that there cannot be large charge densities or electric fields inside a conductive material

Lets see why this is true.....and how deviations from quasi-neutrality disappear.....

Consider an infinite and conductive **N-doped** semiconductor with a net charge density at time $t=0$:



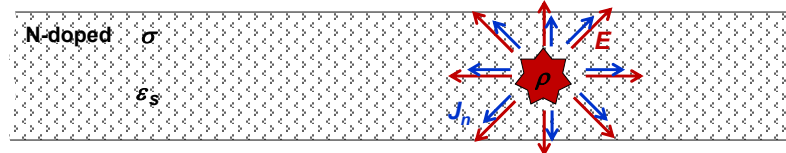
The charge density will generate electric fields (by Gauss' law):



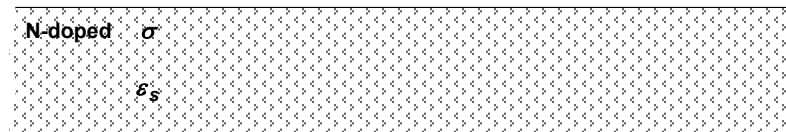
Quasi-Neutrality

The electric field will generate electrical currents:

$$J_n(x, t) = q n(x, t) \mu_n E(x, t) = \sigma E(x, t)$$



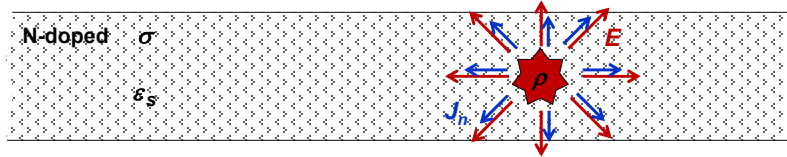
The electrical currents will pile electrons on top of the charge density and neutralize it and then there is no charge density left in the medium.....



This whole process takes a time of the order of the **dielectric relaxation time** τ_d :

$$\tau_d = \frac{\epsilon_s}{\sigma} \sim 10^{-15} - 10^{-13} \text{ Seconds}$$

Appendix: Restoration of Quasi-Neutrality



From Gauss' law:

$$\nabla \cdot \vec{E}(\vec{r}, t) = \frac{\rho(\vec{r}, t)}{\epsilon_s}$$

Current equation:

$$\vec{J}(\vec{r}, t) = \sigma \vec{E}(\vec{r}, t)$$

Use the continuity equation for charge:

$$\begin{aligned} \frac{\partial \rho(\vec{r}, t)}{\partial t} &= -\nabla \cdot \vec{J}(\vec{r}, t) = -\sigma \nabla \cdot \vec{E}(\vec{r}, t) = -\frac{\sigma}{\epsilon_s} \rho(\vec{r}, t) \\ \Rightarrow \frac{\partial \rho(\vec{r}, t)}{\partial t} + \frac{\rho(\vec{r}, t)}{\tau_d} &= 0 \quad \left\{ \begin{array}{l} \tau_d = \frac{\epsilon_s}{\sigma} \end{array} \right. \end{aligned}$$

Solution:

$$\rho(\vec{r}, t) = \rho(\vec{r}, t=0) e^{-\frac{t}{\tau_d}}$$

Charge density in a
conductive medium
disappears on a time
scale of τ_d